

<b>Notice of References Cited</b>	Application/Control No. 10/509,367	Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner TAN X. DINH	Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-6,835,531 B1	12-2004	Yoon et al.	430/270.13
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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